



Sheet 1 of 1

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15540-012001	Application No. 10/695,665
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Michael Glueck		
		Filing Date October 29, 2003	Group Art Unit	

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
PN	AA	4,042,856	08/16/1977	Steigerwald			
	AB	4,251,857	02/17/1981	Shelly			
	AC	4,636,927	01/13/1987	Rhyne et al.			
	AD	4,890,216	12/26/1989	Egawa			
	AE	6,417,729	07/09/2002	Lemay et al.			

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
PN	AF	19943043	03/15/2001	Germany			Abstract	
	AG	3538494A1	05/07/1987	Germany			Abstract	
	AH	3733263A1	04/14/1988	Germany			Abstract	
	AI	01-113195	05/01/1989	Japan			Abstract	
	AJ	04-68117	03/03/1992	Japan			Abstract	
	AK	05-237685	09/17/1993	Japan			Abstract	
	AL	05-269594	10/19/1993	Japan			Abstract	
	AM	61-118220	06/05/1986	Japan			Abstract	
	AN	61-135763	06/23/1986	Japan			Abstract	
	AO	61-292988	12/23/1986	Japan			Abstract	
	AP	62-274012	11/28/1987	Japan			Abstract	
	AQ	62-275593	11/30/1987	Japan			Abstract	
	AR	62-292293	12/18/1987	Japan			Abstract	

Examiner Signature <i>Patricia Nguyen</i>	Date Considered <i>2/4/2005</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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		Filing Date October 29, 2003	Group Art Unit 2817

O I P E S C Y
P A T E N T & T R A D E M A R K O F F I C E

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
PN	AA	6,298,222	10/02/2001	Bergveld et al.			
	AB						
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Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
PN	AL	2,260,871	04/28/1993	GB			
	AM						
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

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